

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/826,383	YOSHIDA ET AL.
	Examiner Khiem D. Nguyen	Art Unit 2823

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	428	2/14/2006	K.N.
257	659	2/14/2006	K.N.
257	660	2/14/2006	K.N.